

Brushless Motor Driver IC for Automotive SPF6001

Description

The SPF6001 is a brushless motor driver IC developed for configuring circuits to match the number of phases of the brushless motor by using multiple units of the IC. The IC is suitable for the applications which the maximum applied voltage to the motor is 150 V or less.

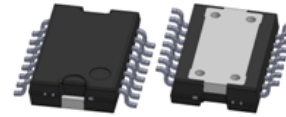
The IC is driven by a bootstrap circuit, and the charge to this boost power supply (boot capacitor) is supplied from the internal auxiliary power supply. This auxiliary power supply is boosted by the internal charge pump circuit and supplies a stable voltage that does not depend on the automotive inherent battery variation to the gate drive circuit.

The IC uses the compact SMD package, HSOP16 with high thermal dissipation and provides high-density mounting. Since the IC has the various protection functions, it can drive brushless motor with few external components.

Features

- AEC-Q100 Qualified
- Built-in Bootstrap Diode
- Built-in Auxiliary Power Supply (VREG)
- Bare Lead Frame: Pb-free (RoHS compliant)
- Enable Function
(All phases shutdown with EN = logic low)
- Fault Signal Output at Protect Circuit Activated
- Protections
 - Simultaneous On-state Prevention
 - VBB Pin Overvoltage Protection (VBB_OVP): Auto-restart
 - Undervoltage Lockout
VBB Pin (VBB_UVLO): Auto-restart
VDD Pin (VDD_UVLO): Auto-restart
VREG Pin (VREG_UVLO): Auto-restart
High-side Driver (S_UVLO): Auto-restart
 - Thermal Shutdown (TSD)

Package HSOP16



Not to scale

Specifications

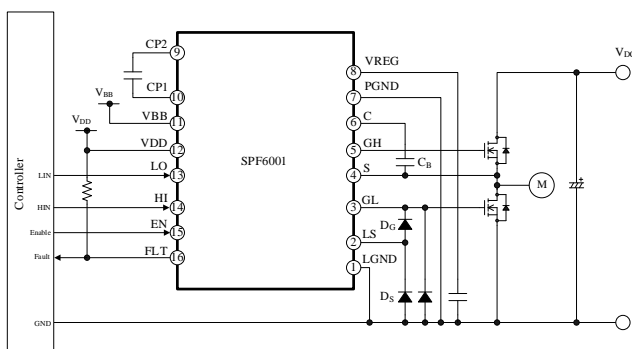
- Maximum Main Supply Voltage: $V_{DC} = 150\text{ V}$
- Maximum Logic Supply Voltage: $V_{BB} = 35\text{ V}$
- Typical On-resistance of Internal Drive Circuit
 - Sink: $4\ \Omega$
 - Source: $5\ \Omega$

Applications

For driving DC brushless motor such as:

- Electronic Power Steering (EPS)
- Integrated Starter Generator (ISG) Hybrid System
- Radiator Pump
- Fan for Air Conditioner

Typical Application



Contents

Description	1
Contents	2
1. Absolute Maximum Ratings	3
2. Recommended Operating Conditions	3
3. Electrical Characteristics	4
4. Mechanical Characteristics	6
5. Block Diagram	7
6. Pin Configuration Definitions	8
7. Typical Application	9
8. Truth Table	10
9. Physical Dimensions	11
10. Marking Diagram	12
11. Operational Descriptions	13
11.1. Pin Descriptions	13
11.1.1. VBB	13
11.1.2. VDD	13
11.1.3. VREG	13
11.1.4. CP1 and CP2	13
11.1.5. C	13
11.1.6. HI and LO	13
11.1.7. EN	13
11.1.8. FLT	13
11.1.9. GH and GL	13
11.1.10. S and LS	14
11.1.11. LGND and PGND	14
11.2. Basic Operation	14
11.3. Simultaneous On-state Prevention	14
11.4. Protections	14
11.4.1. VBB Pin Overvoltage Protection (VBB_OVP)	15
11.4.2. VBB Pin Undervoltage Lockout (VBB_UVLO)	15
11.4.3. VDD Pin Undervoltage Lockout (VDD_UVLO)	15
11.4.4. VREG Pin Undervoltage Lockout (VREG_UVLO)	15
11.4.5. High-side Driver Undervoltage Lockout (S_UVLO)	16
11.4.6. Thermal Shutdown (TSD)	16
11.5. Enable Function	16
Important Notes	17

1. Absolute Maximum Ratings

Current polarities are defined as follows: current going into the IC (sinking) is positive current (+); and current coming out of the IC (sourcing) is negative current (-).

Unless specifically noted, $T_A = 25\text{ }^{\circ}\text{C}$, and reference ground is the LGND pin.

Parameter	Symbol	Conditions	Ratings	Unit
Direct Current Input Voltage	V_{BB}		-0.6 to 35	V
VREG Pin Voltage	V_{REG}		-0.6 to 18	V
VDD Pin Voltage	V_{DD}		-0.3 to 6	V
HI, LO and EN Pin Voltage	V_{IN}		-0.3 to 6	V
LS Pin Voltage	V_{LS}		-4 to 4	V
GL Pin Voltage	V_{GL}		-4 to 18	V
S Pin Voltage	V_S		-4 to 132	V
GH Pin Voltage	V_{GH}		-4 to 150	V
C Pin Voltage	V_C		-0.3 to 150	V
FLT Pin Voltage	V_{FLT}		-0.3 to 6	V
CP1 Pin Voltage	V_{CP1}		-0.3 to 18	V
CP2 Pin Voltage	V_{CP2}		-0.3 to 18	V
Power Dissipation	P_{D1}	Infinite Heatsink	18.6	W
	P_{D2}	Glass-epoxy Board*	2.97	W
Junction Temperature	T_J		-40 to 150	$^{\circ}\text{C}$
Operating Ambient Temperature	T_{OP}		-40 to 105	$^{\circ}\text{C}$
Storage Temperature	T_{STG}		-40 to 150	$^{\circ}\text{C}$
Junction-to-Case Thermal Resistance	θ_{J-C}		6.7	$^{\circ}\text{C}/\text{W}$
Junction-to-Ambient Thermal Resistance	θ_{J-A}		42	$^{\circ}\text{C}/\text{W}$

* Board size is 50 mm × 74 mm, thickness of glass-epoxy is 1.6 mm, and thickness of copper laminate is 18 μm.

2. Recommended Operating Conditions

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
VBB Pin Input Supply Voltage	V_{BB}		7	14	18	V
VDD Pin Input Supply Voltage	V_{DD}		4.5	5.0	5.5	V

3. Electrical Characteristics

Current polarities are defined as follows: current going into the IC (sinking) is positive current (+); and current coming out of the IC (sourcing) is negative current (-).

Unless specifically noted, $T_A = -30\text{ }^{\circ}\text{C}$ to $125\text{ }^{\circ}\text{C}$, $V_{BB} = 14\text{ V}$, $V_{DD} = EN = 5\text{ V}$, $C_{REG} = 10\text{ }\mu\text{F}$, $f_{PWM} = 22.5\text{ kHz}$, and $C_P = C_B = 0.1\text{ }\mu\text{F}$.

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
VBB Input Current 1	I_{BB1}	$V_{DD} = EN = 0\text{ V}$ $HI = LO = 0\text{ V}$	—	3	—	mA
VBB Input Current 2	I_{BB2}	$HI = LO = 0\text{ V}$	—	4	—	mA
VDD Input Current	I_{DD}	$HI = LO = 0\text{ V}$	—	1.0	5.0	mA
C Pin, GH Pin, S Pin Current	I_{CL}	$C = GH = S = 90\text{ V}$	—	—	100	μA
VREG Output Voltage 1	V_{REG1}	$7\text{ V} < V_{BB} < 8\text{ V}$	10	12	18	V
VREG Output Voltage 2	V_{REG2}	$8\text{ V} \leq V_{BB}$	12	15	18	V
Enable Voltage	V_{ENH}	$HI = 5\text{ V}$, $LS = S = LGND$	2.0	—	—	V
Enable Release Voltage	V_{ENL}		—	—	0.8	V
Enable Voltage Hysteresis	ΔV_{EN}		—	0.15	—	V
HI Pin Logic High Input Voltage	V_{HIH}	$LO = 5\text{ V}$, $LS = S = LGND$	2.0	—	—	V
HI Pin Logic Low Input Voltage	V_{HIL}		—	—	0.8	V
HI Pin Input Voltage Hysteresis	ΔV_{HI}		—	0.15	—	V
LO Pin Logic High Input Voltage	V_{LOH}	$HI = 5\text{ V}$, $LS = S = LGND$	2.0	—	—	V
LO Pin Logic Low Input Voltage	V_{LOL}		—	—	0.8	V
LO Pin Input Voltage Hysteresis	ΔV_{LO}		—	0.15	—	V
EN Pin Input Current (H)	I_{ENH}	$EN = 5\text{ V}$	—	100	500	μA
EN Pin Input Current (L)	I_{ENL}	$EN = 0\text{ V}$	-100	—	—	μA
HI Pin Input Current (H)	I_{HIH}	$HI = 5\text{ V}$	—	100	500	μA
HI Pin Input Current (L)	I_{HIL}	$HI = 0\text{ V}$	-100	—	—	μA
LO Pin Input Current (H)	I_{LOH}	$LO = 5\text{ V}$	—	100	500	μA
LO Pin Input Current (L)	I_{LOL}	$LO = 0\text{ V}$	-100	—	—	μA
FLT Pin Output Saturation Voltage	V_{FLT}	$I_{FLT(L)} = 1\text{ mA}$	—	—	0.4	V
Bootstrap Diode Forward Voltage	$V_{TH(BD)}$	$I_F = 1\text{ mA}$	0.4	1.2	1.7	V
GH Pin Source On-resistance	$R_{DS(SC_GH)}$	$HI = 5\text{ V}$, $LO = 0\text{ V}$, $LS = S = LGND$, $C > 10\text{ V}$, $V_{REG} > 10\text{ V}$	6	9	15	Ω
GH Pin Sink On-resistance	$R_{DS(SL_GH)}$		4	6	10	Ω
GL Pin Source On-resistance	$R_{DS(SC_GL)}$	$HI = 0\text{ V}$, $LO = 5\text{ V}$, $LS = S = LGND$, $C > 10\text{ V}$, $V_{REG} > 10\text{ V}$	6	9	1	Ω
GL Pin Sink On-resistance	$R_{DS(SL_GL)}$		4	6	10	Ω
High-side Output Delay Time	$t_{on(H)}$	$C_{iss} = 3300\text{ pF}$, see Figure 3-1	150	250	420	ns
	$t_{off(H)}$		150	200	410	ns
Low-side Output Delay Time	$t_{on(L)}$	$C_{iss} = 3300\text{ pF}$, see Figure 3-1	150	250	420	ns
	$t_{off(L)}$		150	200	410	ns

SPF6001

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
GH Pin Output Rise Time	$t_{r(GH)}$	20% V_{GH} to 80% V_{GH} , $C_{iss} = 3300$ pF, see Figure 3-1	10	50	100	Ns
GH Pin Output Fall Time	$t_{f(GH)}$		10	50	100	ns
GL Pin Output Rise Time	$t_{r(GL)}$	20% V_{GL} to 80% V_{GL} , $C_{iss} = 3300$ pF, see Figure 3-1	10	50	100	ns
GL Pin Output Fall Time	$t_{f(GL)}$		10	50	100	ns
VDD Pin Undervoltage Lockout Release Voltage	$V_{UVDD(H)}$		3.5	4.0	4.5	V
VDD Pin Undervoltage Lockout Operating Voltage	$V_{UVDD(L)}$		3.3	3.8	4.3	V
VDD Pin Undervoltage Lockout Hysteresis	ΔV_{UVDD}		—	0.2	—	V
VBB Pin Overvoltage Protection Operating Voltage	$V_{OVBB(H)}$		24	28	32	V
VBB Pin Overvoltage Protection Release Voltage	$V_{OVBB(L)}$		22	25	31	V
VBB Pin Overvoltage Protection Hysteresis	ΔV_{OVBB}		—	3	—	V
VBB Pin Undervoltage Lockout Release Voltage	$V_{UVBB(H)}$		6.0	6.5	7.0	V
VBB Pin Undervoltage Lockout Operating Voltage	$V_{UVBB(L)}$		5.5	6.1	6.6	V
VBB Pin Undervoltage Lockout Hysteresis	ΔV_{UVBB}		—	0.4	—	V
VREG Pin Undervoltage Lockout Release Voltage	$V_{UVREG(H)}$		6.5	7.5	8.5	V
VREG Pin Undervoltage Lockout Operating Voltage	$V_{UVREG(L)}$		6.0	7.1	8.2	V
VREG Pin Undervoltage Lockout Hysteresis	ΔV_{UVREG}		—	0.4	—	V
High-side Driver Undervoltage Lockout Operating Voltage	$V_{UVS(L)}$		8.4	9.4	10.8	V
High-side Driver Circuit Current	I_{CS1}	$V_{SC} = 10$ V	0	—	240	μ A
	I_{CS2}	$V_{SC} = 14$ V	0	—	480	μ A
Thermal Shutdown Starting Temperature*	T_{TSD}		151	—	—	$^{\circ}$ C

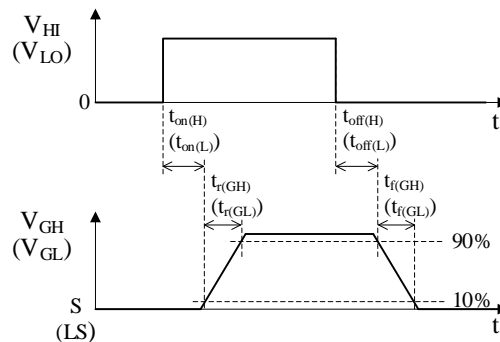


Figure 3-1. Definition of Switching Time

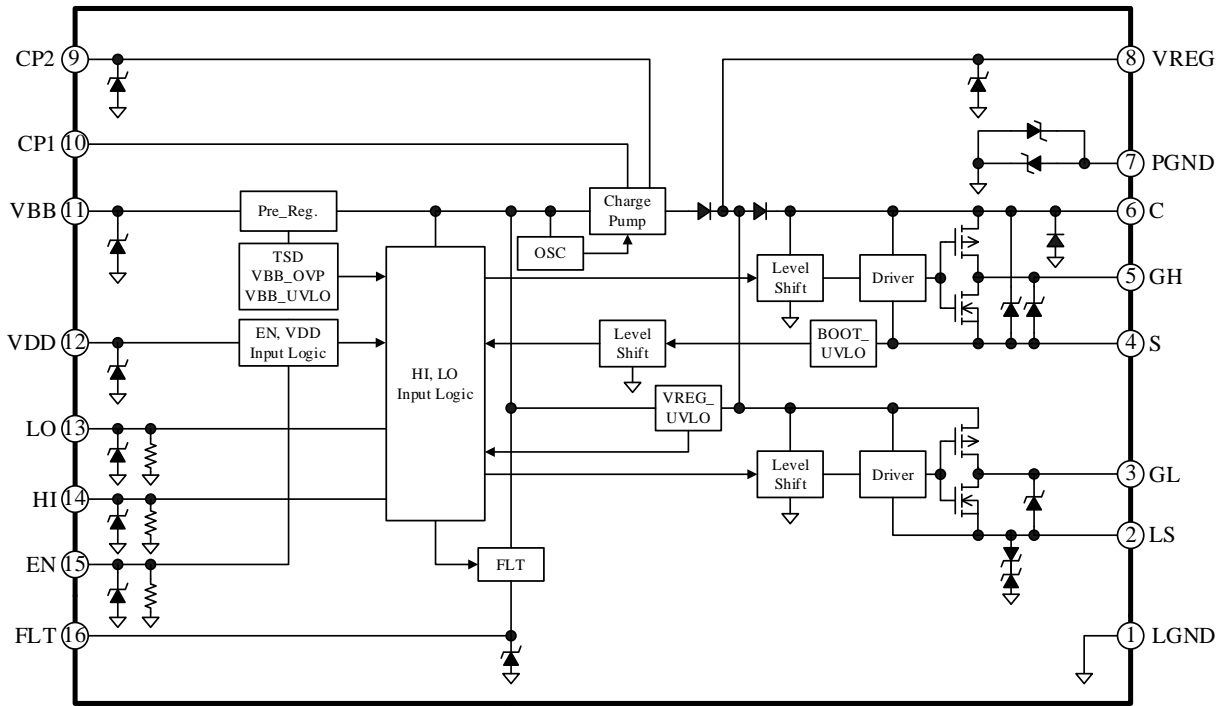
* It is guaranteed by design. The typical design value of thermal shutdown starting temperature is 165 $^{\circ}$ C.

SPF6001

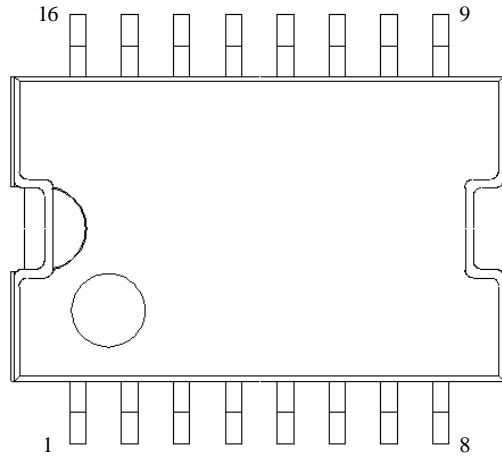
4. Mechanical Characteristics

Parameter	Min.	Typ.	Max.	Unit
Package Weight	—	0.87	—	g

5. Block Diagram



6. Pin Configuration Definitions



Pin Number	Pin Name	Function
1	LGND	Control ground
2	LS	Low-side source connection
3	GL	Low-side gate drive signal output
4	S	High-side source connection
5	GH	High-side gate drive signal output
6	C	Boot capacitor connection
7	PGND	Power ground
8	VREG	Capacitor connect pin for high-and low-side gate drive
9	CP2	Capacitor connect pin 2 for charge pump circuit
10	CP1	Capacitor connect pin 1 for charge pump circuit
11	VBB	Main supply input
12	VDD	Logic supply input for input signal
13	LO	Low side logic input
14	HI	High side logic input
15	EN	Enable signal input
16	FLT	Fault signal output (Open drain)

7. Typical Application

In the case of the application so that the LS pin voltage exceeds the absolute maximum rating of ± 4 V, a diode, D_S , must be added between the LS pin and the LGND pin.

If the GL pin voltage becomes lower by about 0.6 V to 1.8 V than the LS pin voltage, the IC may be damaged. To avoid the situation, a diode, D_G , must be added between the GL pin and the LS pin.

D_S and D_G must be placed near the IC, and connected with a minimal length of traces.

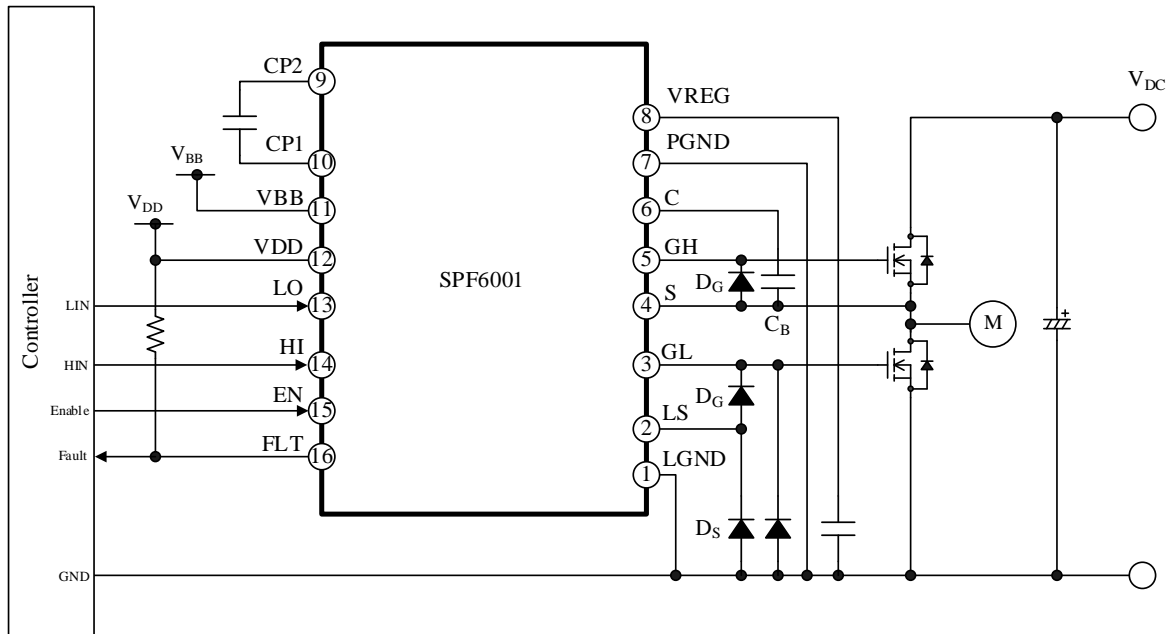


Figure 7-1. Typical Application

8. Truth Table

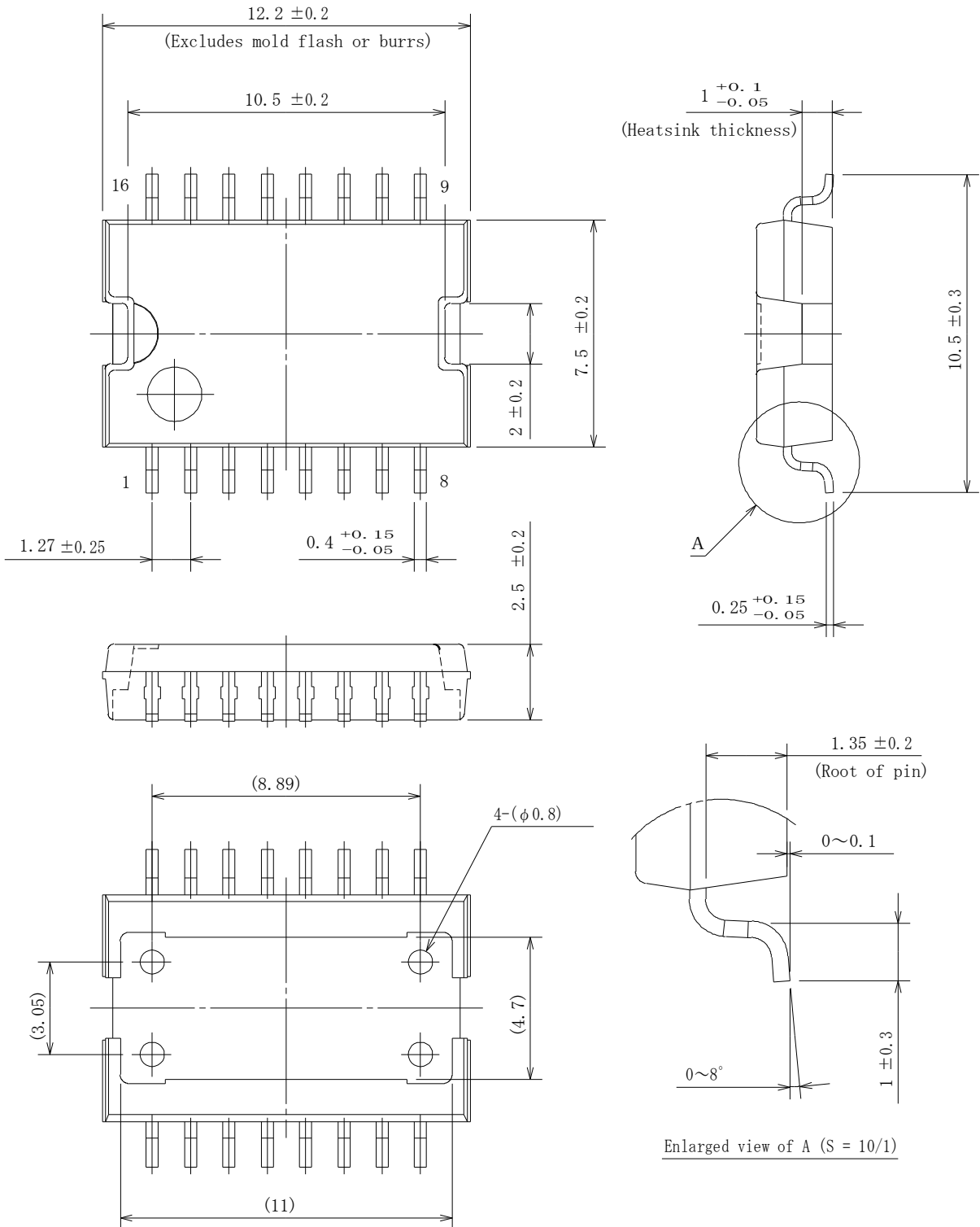
Table 8-1. Truth Table for Operation Modes

Mode	Input Pin		Output Pin			Remarks
	HI	LO	GH	GL	FLT*	
Normal Operation	L	L	L	L	H	
	H	L	H	L	H	
	L	H	L	H	H	
	H	H	L	L	H	Simultaneous On-state Prevention
VBB Pin Undervoltage Lockout (VBB_UVLO)	L	L	L	L	L	
	H	L	L	L	L	
	L	H	L	L	L	
	H	H	L	L	L	
VDD Pin Undervoltage Lockout (VDD_UVLO)	L	L	L	L	L	
	H	L	L	L	L	
	L	H	L	L	L	
	H	H	L	L	L	
Enable Signal Input (EN pin is low level)	L	L	L	L	H	
	H	L	L	L	H	
	L	H	L	L	H	
	H	H	L	L	H	
VREG Pin Undervoltage Lockout (VREG_UVLO)	L	L	L	L	L	
	H	L	H	L	L	
	L	H	L	H	L	
	H	H	L	L	L	Simultaneous On-state Prevention
High-side Driver Undervoltage Lockout (S_UVLO)	L	L	L	L	L	
	H	L	H	L	L	
	L	H	L	H	L	
	H	H	L	L	L	
Thermal Shutdown (TSD)	L	L	L	L	L	
	H	L	L	L	L	
	L	H	L	L	L	
	H	H	L	L	L	

*The FLT pin is pulled up to the VDD pin.

9. Physical Dimensions

• HSOP16 Package

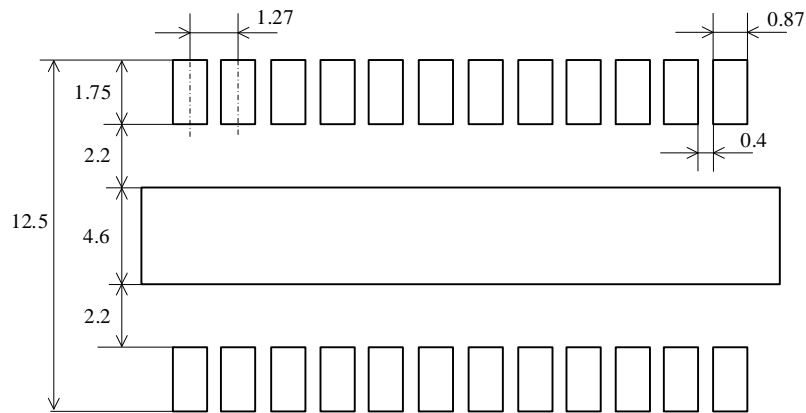


NOTES:

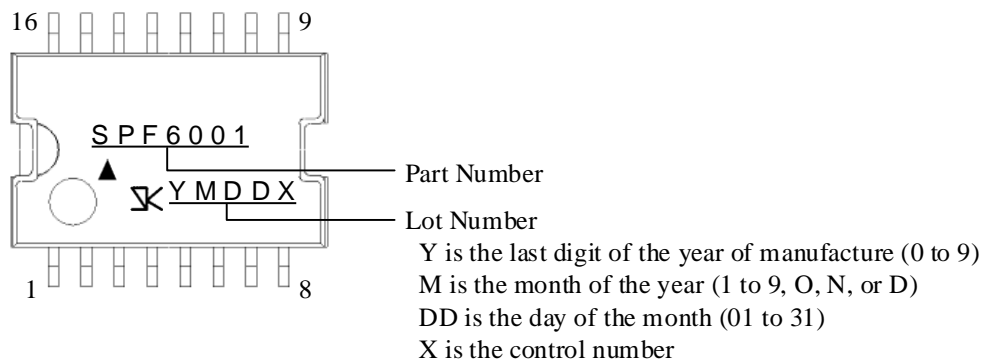
- Dimensions in millimeters
- Bare lead frame: Pb-free (RoHS compliant)

SPF6001

• HSOP16 Land Pattern Example



10. Marking Diagram



11. Operational Descriptions

All the characteristic values given in this section are typical values, unless they are specified as minimum or maximum. Current polarities are defined as follows: current going into the IC (sinking) is positive current (+); and current coming out of the IC (sourcing) is negative current (-).

11.1. Pin Descriptions

11.1.1. VBB

This is the main supply input pin of the IC. Recommended applied voltage to the VBB pin is 7 V to 18 V.

When the same power supply is connected to the VBB pin and the external output transistors, power supply loop trace should be designed as wide and short as possible. A Bypass capacitor for noise reduction should be connected to the VBB pin as needed. The bypass capacitor should be placed near the VBB pin, and connected to the VBB pin with a minimal length of traces.

11.1.2. VDD

This is the supply input for input logic circuit. Recommended applied voltage to the VDD pin is 4.5 V to 5.5 V.

11.1.3. VREG

The power supply of high- and low-side gate drive circuit is generated by the internal charge pump circuit. Thus, the gate can be driven stably even if the VBB pin voltage is low (7 V or more).

Capacitor (10 μ F or more is recommended) for holding supply voltage of gate drive circuit should be connected to the VREG pin. External power supply connection is unnecessary.

11.1.4. CP1 and CP2

Connect a capacitor for internal charge pump circuit between the CP1 pin and the CP2 pin. The recommended capacitance is 0.1 μ F.

11.1.5. C

Connect a high-side boot capacitor, C_B , between the C pin and the S pin. The recommended capacitance of C_B is 0.1 μ F or more. Since the capacitance depends on the

drive frequency and control duty, the setting is required according to the application. For proper startup, turn on the low-side output transistors first, and then charge C_B up to its maximum capacity.

11.1.6. HI and LO

These are the signal input pins. The HI pin acts as high-side controller whereas the LO pin acts as low-side controller. Since the HI and LO pins incorporate a pull-down resistor, the initial state is low (see the block diagram in Section 4).

The width of the input signals to the HI and LO pins is required 500 ns or more.

Note that dead time setting for the input signals of the HI and LO pins must be done because the IC does not have a dead time generator. Dead time must be set so that the simultaneous on-state does not occur according to the output transistors to be used.

11.1.7. EN

When the high signal is input to the EN pin, all output signals of the GH and GL pins become logic low. Since the EN pin incorporates a pull-down resistor, the initial state is low (see the block diagram in Section 4).

11.1.8. FLT

This is the output pin of fault signal. Pull up the FLT pin because the FLT pin is open drain. When the FLT pin is pulled up to the power supply of 5 V, the recommended pull-up resistor is about 20 k Ω . The FLT pin logic level is high in normal operation, and becomes low when one or more the following protections are activated.

- VBB pin Overvoltage Protection (VBB_OVP)
- VBB pin Undervoltage Lockout (VBB_UVLO)
- VDD pin Undervoltage Lockout (VDD_UVLO)
- VREG pin Undervoltage Lockout (VREG_UVLO)
- High-side driver Undervoltage Lockout (S_UVLO)
- Thermal Shutdown (TSD)

11.1.9. GH and GL

These are the gate drive outputs, and are connected to the gate of external output transistors. The GH pin acts as high-side controller whereas the GL pin acts as low-side controller. A pull-down resistor of 100 k Ω (typ.) and protection Zener diodes (the Zener diode) of 18 V (typ.) are internally connected between the GH pin and the S pin, and between the GL pin and the LS pin respectively (see Figure 11-1 and Figure 11-2).

When the current from motor flows to the forward direction of this Zener diode, this may be damaged. In

the application that the current flows to the forward direction of the Zener diode, an external diode, D_G , must be added between the GH pin and the S pin, and between the GL pin and the LS pin respectively (see Figure 7-1).

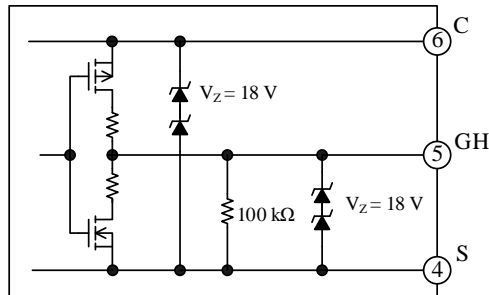


Figure 11-1. Internal Circuit of High-side Output

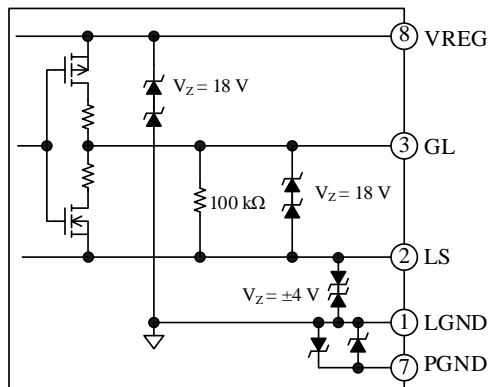


Figure 11-2. Internal Circuit of Low-side Output

11.1.10. S and LS

Connect the S pin to the source pin of high-side output transistors and the drain pin of low-side output transistors, and the LS pin to the source pin of low-side output transistors.

An ESD protection bidirectional Zener diode of ± 4 V is internally connected between the LS pin and the LGND pin (see Figure 11-2). In the application that the voltage of ± 4 V or more is applied between the S pin and the LGND pin, the external diode, D_S , must be connected between the LS pin and the LGND pin (see Figure 7-1).

11.1.11. LGND and PGND

The LGND pin is control ground of the IC. The PGND pin is power ground. A Zener diode is internally connected bidirectionally between the LGND pin and the PGND pin in parallel (see Figure 11-2).

11.2. Basic Operation

At startup, the voltage is applied to the VBB and VDD pins which are the power supply of the IC. Then, the high signal is input to the EN pin. After that, input the signal to the HI and LO pins; and on/off controls of the output transistors start.

When the high signal is input to the HI pin, high-side gate output (the GH pin) becomes logic high. When the high signal is input to the LO pin, low-side gate output (the GL pin) becomes logic high (see Table 8-1).

The EN pin has an internally low-pass filter of $2.5 \mu\text{s}$ for the noise malfunction prevention. The HI and LO pins do not have internal low-pass filter.

11.3. Simultaneous On-state Prevention

When the high signal is input to the HI and LO pins at once, the Simultaneous On-state Prevention is activated, and the outputs of the GH and GL pins become logic low. This prevents the breakdown of the output transistors.

11.4. Protections

The IC has the following protection functions.

When the following protections are activated, the outputs of the GH and GL pins become logic low, and stop the output transistors. In addition, the fault signal is output (the FLT pin logic level becomes low).

When the protection is released after the fault conditions are removed, the FLT output becomes logic high. Then, the GH and GL pins restart output the signals according to the input commands on the HI and LO pins from the next falling edge.

However, during VREG_UVLO is activated, the IC outputs the fault signal with maintaining the outputs of the GH and GL pins according to input signal.

- VBB Pin Overvoltage Protection (VBB_OVP)
- VBB Pin Undervoltage Lockout (VBB_UVLO)
- VDD Pin Undervoltage Lockout (VDD_UVLO)
- VREG Pin Undervoltage Lockout (VREG_UVLO)
- High-side Driver Undervoltage Lockout (S_UVLO)
- Thermal Shutdown (TSD)

11.4.1. VBB Pin Overvoltage Protection (VBB_OVP)

When the VBB pin voltage increases to the VBB pin overvoltage protection operating voltage $V_{OVBB(H)} = 28$ V or more, VBB_OVP is activated. When the VBB pin voltage decreases to the release voltage $V_{OVBB(L)} = 25$ V or less, the IC returns to the normal operation.

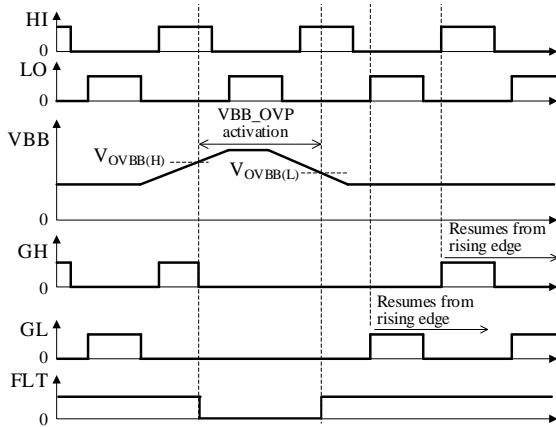


Figure 11-3. Operational Waveform of VBB_OVP

11.4.2. VBB Pin Undervoltage Lockout (VBB_UVLO)

The VBB pin voltage decrease to the VBB pin undervoltage lockout operating voltage $V_{UVBB(L)} = 6.1$ V or less, VBB_UVLO is activated. When the VBB pin voltage increases to the release voltage $V_{UVBB(H)} = 6.5$ V or more, the IC returns to the normal operation. During the VBB_UVLO activation, the internal charge pump circuit (OSC circuit operation is maintained) and the VREG pin boost operation are stopped.

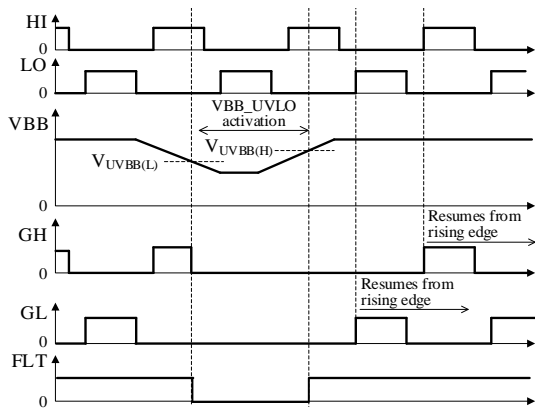


Figure 11-4. Operational Waveform of VBB_UVLO

11.4.3. VDD Pin Undervoltage Lockout (VDD_UVLO)

When the VDD pin voltage decreases to the VDD pin undervoltage lockout operating voltage $V_{UVDD(L)} = 3.8$ V or less, the VDD_UVLO is activated.

When the VDD pin voltage increases to the release voltage $V_{UVDD(H)} = 4.0$ V or more, the IC returns to the normal operation.

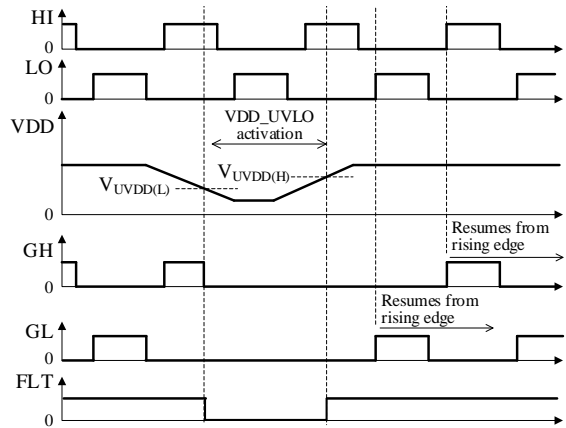


Figure 11-5. Operational Waveform of VDD_UVLO

11.4.4. VREG Pin Undervoltage Lockout (VREG_UVLO)

When the VREG pin voltage decreases to VREG pin undervoltage lockout operating voltage $V_{UVREG(L)} = 7.1$ V or less due to the leak current of the capacitor connecting to the VREG pin, the VREG_UVLO is activated.

When the VREG pin voltage increases to the release voltage $V_{UVREG(H)} = 7.5$ V or more, the IC returns to the normal operation.

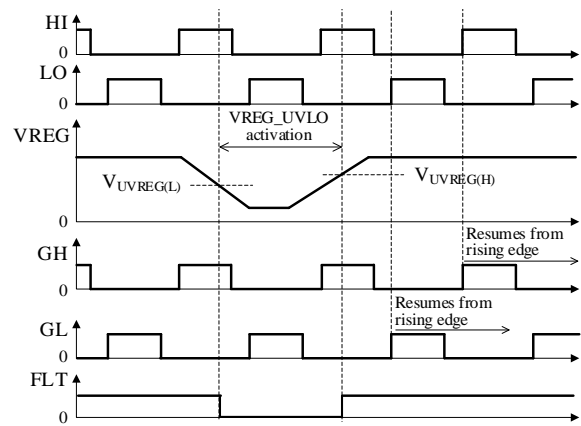


Figure 11-6. Operational Waveform of VREG_UVLO

11.4.5. High-side Driver Undervoltage Lockout (S_UVLO)

The SPF6001 incorporates the high-side driver undervoltage lockout (S_UVLO) between the S and C pins. The voltage between S and C pins decrease to the high-side driver undervoltage lockout operating voltage $V_{UVS(L)} = 9.4\text{ V}$ or less, S_UVLO is activated.

When the voltage between S and C pins increases to 9.5 V or more, the IC returns to its normal operation.

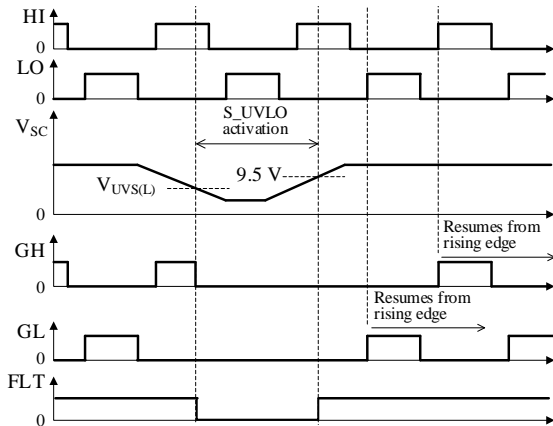


Figure 11-7. Operational Waveform of S_UVLO

11.4.6. Thermal Shutdown (TSD)

When the junction temperature of the IC increases to $T_{TSD} = 151\text{ }^{\circ}\text{C}$ (min.) or more, the TSD is activated. The design value of TSD operating temperature is $165\text{ }^{\circ}\text{C}$ (typ.). TSD has the temperature hysteresis. When the temperature decreases by about $10\text{ }^{\circ}\text{C}$ from the junction temperature of TSD operation, TSD is released, and the IC returns to the normal operation.

TSD protects the IC against instantaneous heat generation, and does not guarantee the operation including reliability for a state that the heat generation continues for a long time.

11.5. Enable Function

The IC has an enable function.

When the low signal (0.8 V or less) is input to the EN pin, the input signals of the GH and GL pins become logic low. When the high signal (2.0 V or more) is input to the EN pin, the GH and GL pins restart output the signals according to the input commands on the HI and LO pins from the next rising edge. During the EN pin logic is low, the FLT pin logic level is maintained high.

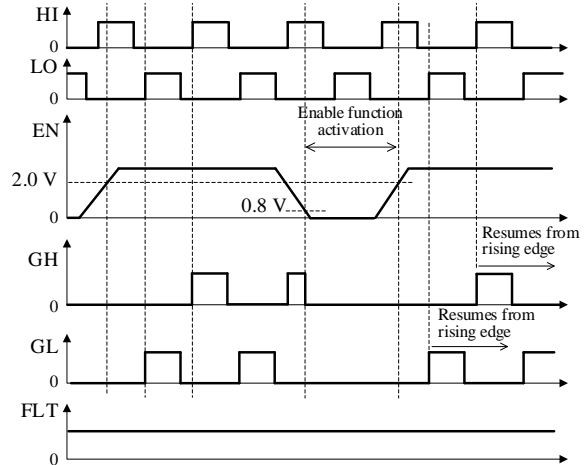


Figure 11-8 Operational Waveform of Enable Function

Important Notes

- All data, illustrations, graphs, tables and any other information included in this document (the “Information”) as to Sanken’s products listed herein (the “Sanken Products”) are current as of the date this document is issued. The Information is subject to any change without notice due to improvement of the Sanken Products, etc. Please make sure to confirm with a Sanken sales representative that the contents set forth in this document reflect the latest revisions before use.
- The Sanken Products are intended for use as components of electronic equipment or apparatus (transportation equipment and its control systems, home appliances, office equipment, telecommunication equipment, measuring equipment, etc.). Prior to use of the Sanken Products, please put your signature, or affix your name and seal, on the specification documents of the Sanken Products and return them to Sanken. If considering use of the Sanken Products for any applications that require higher reliability (traffic signal control systems or equipment, disaster/crime alarm systems, etc.), you must contact a Sanken sales representative to discuss the suitability of such use and put your signature, or affix your name and seal, on the specification documents of the Sanken Products and return them to Sanken, prior to the use of the Sanken Products. The Sanken Products are not intended for use in any applications that require extremely high reliability such as: aerospace equipment; nuclear power control systems; and medical equipment or systems, whose failure or malfunction may result in death or serious injury to people, i.e., medical devices in Class III or a higher class as defined by relevant laws of Japan (collectively, the “Specific Applications”). Sanken assumes no liability or responsibility whatsoever for any and all damages and losses that may be suffered by you, users or any third party, resulting from the use of the Sanken Products in the Specific Applications or in manner not in compliance with the instructions set forth herein.
- In the event of using the Sanken Products by either (i) combining other products or materials or both therewith or (ii) physically, chemically or otherwise processing or treating or both the same, you must duly consider all possible risks that may result from all such uses in advance and proceed therewith at your own responsibility.
- Although Sanken is making efforts to enhance the quality and reliability of its products, it is impossible to completely avoid the occurrence of any failure or defect or both in semiconductor products at a certain rate. You must take, at your own responsibility, preventative measures including using a sufficient safety design and confirming safety of any equipment or systems in/for which the Sanken Products are used, upon due consideration of a failure occurrence rate and derating, etc., in order not to cause any human injury or death, fire accident or social harm which may result from any failure or malfunction of the Sanken Products. Please refer to the relevant specification documents and Sanken’s official website in relation to derating.
- No anti-radioactive ray design has been adopted for the Sanken Products.
- The circuit constant, operation examples, circuit examples, pattern layout examples, design examples, recommended examples, all information and evaluation results based thereon, etc., described in this document are presented for the sole purpose of reference of use of the Sanken Products.
- Sanken assumes no responsibility whatsoever for any and all damages and losses that may be suffered by you, users or any third party, or any possible infringement of any and all property rights including intellectual property rights and any other rights of you, users or any third party, resulting from the Information.
- No information in this document can be transcribed or copied or both without Sanken’s prior written consent.
- Regarding the Information, no license, express, implied or otherwise, is granted hereby under any intellectual property rights and any other rights of Sanken.
- Unless otherwise agreed in writing between Sanken and you, Sanken makes no warranty of any kind, whether express or implied, including, without limitation, any warranty (i) as to the quality or performance of the Sanken Products (such as implied warranty of merchantability, and implied warranty of fitness for a particular purpose or special environment), (ii) that any Sanken Product is delivered free of claims of third parties by way of infringement or the like, (iii) that may arise from course of performance, course of dealing or usage of trade, and (iv) as to the Information (including its accuracy, usefulness, and reliability).
- In the event of using the Sanken Products, you must use the same after carefully examining all applicable environmental laws and regulations that regulate the inclusion or use or both of any particular controlled substances, including, but not limited to, the EU RoHS Directive, so as to be in strict compliance with such applicable laws and regulations.
- You must not use the Sanken Products or the Information for the purpose of any military applications or use, including but not limited to the development of weapons of mass destruction. In the event of exporting the Sanken Products or the Information, or providing them for non-residents, you must comply with all applicable export control laws and regulations in each country including the U.S. Export Administration Regulations (EAR) and the Foreign Exchange and Foreign Trade Act of Japan, and follow the procedures required by such applicable laws and regulations.
- Sanken assumes no responsibility for any troubles, which may occur during the transportation of the Sanken Products including the falling thereof, out of Sanken’s distribution network.
- Although Sanken has prepared this document with its due care to pursue the accuracy thereof, Sanken does not warrant that it is error free and Sanken assumes no liability whatsoever for any and all damages and losses which may be suffered by you resulting from any possible errors or omissions in connection with the Information.
- Please refer to our official website in relation to general instructions and directions for using the Sanken Products, and refer to the relevant specification documents in relation to particular precautions when using the Sanken Products.
- All rights and title in and to any specific trademark or tradename belong to Sanken and such original right holder(s).

DSGN-AEZ-16003